DEC 0 8 2000 Substitute Form PTO-1449 (Modulated) Information

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 16105-002US2

Application No. 10/646,428

Information Disclosure Statement by Applicant (Use several sheets if necessary)

David Hawley

Applicant

Filing Date Group Art Unit ... August 21, 2003

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
SR	AA	5,335,320	08/02/94	Iwata et al.			
AB							

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Trans Yes	lation No
SR	AC	WO 99/04349	01/28/99	PCT .				

	Other D	ocuments (include Author, Title, Date, and Place of Publication)
Examiner	Desig.	
Initial	ID	Document
SR	AD	Abrams and Phanouriou, "UIML: An XML Language for Building Device-Independent User Interfaces," XML Conference Proceedings – Proceedings of XML, XX, XX, December 1999, 46 pgs.
SR	AE	Abrams, "User Interface Markup Language (UIML) Draft Specification," Document Version 17 January 2000, Language Version 2.0a, Copyright 2000 Harmonia, Inc., 64 pgs., Retrieved from the Internet: http://www.uiml.org/specs/docs/uiml20
SR	AF	Hyatt, "The XPToolkit Architecture (TOC, Introduction, Overview of Packages)," Mozilla Cross-Platform (XP) Toolkit Documentation, 7 pgs., Retrieved from the Internet: http://www.mozilla.org/xpfe/xptoolkit; Accessed Date: Unknown
	AG	

Examiner Signature

/Satish Rampuria/ (01/05/2007)

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Chase	1	-6	1
Sheet	1	of	

Substitute Form PTC	U.S. Department of Commerce Patent and Trademark Office		Application No. 10/646,428
(S 2002 \$	ation Disclosure Statement by Applicant	Applicant David Hawley	
(U)	se several sheets if necessary)	Filing Date August 21, 2003	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Desig. Document Publication Country or						Translation		
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AD							
	AE						·	

. (Other Documents (include Author, Title, Date, and Place of Publication)							
Examiner Initial	Desig. ID	Document						
SR	AF	http://www.gca.org/attend/1999 conferences/xml 99/xml99 7tracks.htm - XML -1999 Enabling Business Innovation on the Web Conference Agenda, printed from the Internet February 10, 2003, 31 pgs.						
	AG							

Examiner Signature	Date Considered	
/Satish Rampuria/ (01/05/2007)		•
EXAMINED: Initials citation considered. Draw line through citation if a	at in conformance and not considered, inclu	do cook of this form with

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.